

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/653,667	LEE, SUNG-DAE	
Examiner	Art Unit	
Kieu D. Vu	2173	

SEARCHED						
SEARCHED						
Class	Subclass	Date	Examiner			
715	703	7/26/2007	KV			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR) (See Search History Printout)	7/26/2007	κv	